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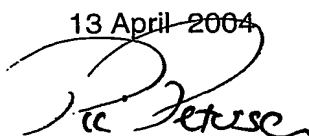
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PATENT- OG VAREMÆRKESTYRELSEN

A Chemical Sensor***Field of the invention***

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The present invention relates to a chemical sensor comprising one or more sensor units in the form of cantilevers with a piezoresistive element and means for applying a voltage over said piezoresistive element.

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Background of the invention

Sensors of the above type are well known from the literature and are e.g. disclosed in WO 00/66266.

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From stress formation studies in ambient and aqueous environments, micrometer-sized cantilevers with optical read-out have proven very sensitive as described in the articles Berger, R., Gerber, Ch., Lang, H.P. & Gimzewski, J.K. Micromechanics: A toolbox for femtoscale science: "Towards a laboratory on a tip". *Microelectronic Engineering*. **35**, 373-379 (1997), and O'Shea, S.J., Welland, M.E. Atomic force Microscopy stress sensors for studies in liquids. *J. Vac. Sci. Technol. B*. **14**, 1383-1385 (1996).

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A particularly promising application is for detection of molecular interaction, where capture molecules are immobilized on the surface of the cantilever. A surface stress is induced when target molecules bind to the capture molecules on the cantilever. The surface stress change obtained due to the molecular interaction can be

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detected by integrating a stress sensitive piezoresistor into the cantilever. By integrating the piezoresistor in a Wheatstone bridge, the resistance change due to the surface stress change is transformed into a change in voltage. Other types of mechanical sensors that are sensitive to surface stress include micro bridges and membranes.

Basically, a biochemical reaction at the cantilever surface can be monitored as a bending or stretch of the cantilever due to a change in the surface stress. Surface stress changes in self-assembled alkanethiols on gold have earlier been measured in air by this technique, and surface stress changes of approximately 10^{-5} N/m can be resolved by cantilever-based methods. This sensor principle has a wide range of applications in the detection of specific biomolecules as well as in real time local monitoring of chemical and biological interactions.

Cantilever-based sensors with integrated piezoresistive read-out are described by Thaysen, J., Boisen, A., Hansen, O. & Bouwstra, S. AFM probe with piezoresistive read-out and highly symmetrical Wheatstone bridge arrangement. *Proceedings of Transducers '99*, 1852-1855 (Sendai 1999). Hereby the stress changes on the cantilever sensors can be registered directly by the piezoresistor. Each sensor has a built-in reference cantilever, which makes it possible to subtract background drift directly in the measurement. The two cantilevers are connected in a Wheatstone bridge, and the

stress change on the measurement cantilever is detected as the output voltage from the Wheatstone bridge.

Sensors comprising sensor units in the form of cantilevers with a piezoresistive element for direct read out are relatively small. This is often advantageous when measuring in liquid samples, as the amount of sample necessary to perform a measurement can be relatively small. Thus it is of course also important to be able to handle such small sample i.e. it is important to provide a small liquid chamber where the sample can be contacted with the cantilever or cantilevers.

In the prior art sensors, e.g. as disclosed in "cantilever-based bio-chemical sensor integrated in a microliquid handling system" by J. Thaysen et al. 0-7803-5998-4/01 2001 IEEE, the sensor unit is mounted on a plate so that the cantilevers protrude into a liquid channel and the piezoresistive elements are wire bonded. The resulting chip and the liquid chamber thereby become relatively large compared to the size of the cantilever.

Summary of the invention

The object of the present invention is to provide a chemical sensor which can be produced in a simple way, and where it is possible to optimise the size of the liquid chamber relative to the size of the cantilever.

An additional objective of the invention is to provide a sensor which may comprise an array of piezoresistor sensor units for direct read-out, wherein the amount of

liquid necessary to perform the measurements is relatively small and simultaneously the risk of short circuiting is low.

- 5 These and other objectives have been achieved by the invention as defined in the claims.

Disclosure of the invention

- 10 The chemical sensor of the invention comprises one or more sensor units, such as 1, 2, 5, 10, 50 or even more e.g. up to 100 or 300 sensor units, such as it is disclosed in WO 0066266, PCT/DK/0200779, PCT/DK/0300117, PCT/DK/0300042, PCT/DK/0300086, DK PA 2002 00884, DK PA
15 2002 01221, and DK PA 2002 00068, which with respect to the disclosure concerning sensor unit structure in the form of cantilevers (also including cantilever like structures and polycantilevers as disclosed in PCT/DK/0300086, PCT/DK/0300042 and DK PA 2002 00068),
20 size of the cantilever, materials, and type of capture surface are hereby incorporated by reference.

- The one or more sensor units are in the form of cantilevers. This should be interpreted so that the
25 sensor units may have any cantilever like shape e.g. as the cantilevers described in PCT/DK/0300042 and DK PA 2002 00068. The term "cantilever" is defined as a sheet formed unit linked to a substrate along one or two opposite edge lines. The term "cantilever" thus also
30 includes a bridge as well as a traditional rectangular or leaf-shaped cantilever.

In one embodiment, the sensor unit shaped as a cantilever with a longitudinal direction is linked in both of its longitudinal endings to form a cantilevered bridge.

- 5 In another embodiment, the cantilever is a traditional rectangular or leaf-shaped cantilever linked to and protruding from one substrate. This shape is further disclosed in DK PA 2002 00068
- 10 The thickness of the cantilever may preferably be between 0.1 and 25 μm , more preferably between 0.3 and 5 μm , such as about 1 μm . The length and width may e.g. be up to about 500 μm , more preferably up to about 100 μm , such as about 50 μm , and the width may e.g. between 0.05 and 0.5
- 15 times its length.

Each of the cantilevers comprises a piezoresistive element for direct read out e.g. as disclosed in WO 0066266, PCT/DK/0200779, PCT/DK/0300117, PCT/DK/0300042,

20 PCT/DK/0300086, DK PA 2002 00884, DK PA 2002 01221, and DK PA 2002 00068.

The piezoresistor may be any kind of resistor capable of changing resistivity due to a deformation provided by

25 deflecting and/or stretching of the sensor unit. Piezoresistors are well known in the art and are e.g. described in the following publications which are hereby incorporated by reference: US 6237399, US 5907095, Berger, R. et al. Surface stress in the self-assembly of

30 alkanethiols on gold. *Science*. **276**, 2021-2024 (1997); Berger, R., Gerber, Ch., Lang, H.P. & Gimzewski, J.K. *Micromechanics: A toolbox for femtoscale science:*

"Towards a laboratory on a tip". *Microelectronic Engineering*. **35**, 373-379 (1997); Thaysen, J., Boisen, A., Hansen, O. & Bouwstra, S. AFM probe with piezoresistive read-out and highly symmetrical Wheatstone bridge arrangement. *Proceedings of Transducers'99*, 1852-1855 (Sendai 1999); Boisen A., Thaysen J., Jensenius H., & Hansen, O. Environmental sensors based on micromachined cantilevers with integrated read-out. *Ultramicroscopy*, **82**, 11-16 (2000).

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Preferred piezoresistors include piezoresistors of a material selected from the group consisting of one or more of the materials silicon (including polysilicon and single crystal silicon), metal or metal containing composition, e.g. gold, AlN, Ag, Cu, Pt and Al conducting polymers, such as doped octafunctional epoxidized novalac e.g. doped SU-8, and composite materials with an electrically non-conducting matrix and a conducting filler, wherein the filler preferably is selected from the group consisting of polysilicon, single crystal silicon, metal or metal containing composition, e.g. gold, AlN, Ag, Cu, Pt and Al, semi-conductors, carbon black, carbon fibres, particulate carbon, carbon nanowires, silicon nanowires.

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Even though the sensor in the following mainly is described with one cantilever it should be understood that the sensor could comprise several as mentioned above, e.g. arranged in a row or several rows.

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The sensor comprises a primary and a secondary substrate. The primary substrate comprises a primary cavity and the

sensor unit or units are connected to and protruding from said primary substrate and into said primary cavity. The primary cavity thus constitutes the whole or part of a chamber or channel for a liquid sample, where the liquid
 5 sample can come into contact with the cantilever(s). This chamber/channel is also denoted an interaction chamber.

The primary substrate may in principle be of any material and shape as disclosed in WO 0066266, PCT/DK/0200779,
 10 PCT/DK/0300117, PCT/DK/0300042, PCT/DK/0300086, DK PA 2002 00884, DK PA 2002 01221, and DK PA 2002 00068.

In one embodiment, the primary substrate comprises one or more of the materials selected from the group consisting
 15 of silicon (including polysilicon and single crystal silicon), silicon nitride, silicon oxide, metal, metal oxide, glass and polymer, wherein the group of polymers preferably includes epoxy resin e.g. an octafunctional epoxidized novalac, polystyrene, polyethylene, polyvinyl
 20 acetate, polyvinylchloride, polyvinylpyrrolidone, polyacrylonitrile, polymethylmetacrylate, polytetrafluoroethylene, polycarbonate, poly-4-methylpentylene, polyester, polypropylene, cellulose, nitrocellulose, starch, polysaccharides, natural rubber,
 25 butyl rubber, styrene butadiene rubber and silicon rubber.

In one embodiment, the primary substrate is based on silicon, said primary cavity being in the form of an
 30 etched cavity forming a recess under the one or more cantilever(s), e.g. as disclosed in WO 0066266.

In order to have good processability, it may be desired that the primary substrate is of or comprises a material

which can act as a photo resist. Preferred materials include an epoxy resin, preferably selected from the group consisting of epoxy functional resin having at least two epoxy groups, preferably an octafunctional epoxidized novalac. Particularly preferred materials are described in US 4882245, which are hereby incorporated by reference. The most preferred material is the octafunctional epoxidized novalac which is commercially available from Celanese Resins, Shell Chemical, MicroChem Inc. under the trade name SU-8, and from Softec Microsystems under the trade name SM10#0.

Basically, it is preferred that the cantilevers are based on a material included in the primary substrate or preferably based on the same material as that of the primary substrate. If the sensor unit and the primary substrate are made in one piece, it is naturally based on the same material, but the sensor unit and the primary substrate may include one or more layers of material not included in the other part. To be based on a material means in the invention that at least 75 %, preferably at least 90% by volume is constituted by this material.

A primary connecting surface at least partly surrounds the primary cavity. In one embodiment, the primary connecting surface totally surrounds the primary cavity.

The primary connection cavity may in one embodiment be close to the border of the cavity, such as at a distance of 20 μm or less, such as 10 μm or less, such as 5 μm or less. In one embodiment, the primary connection surface is at a distance from the primary cavity border of between 25 and 500 μm , such as between 50 and 150 μm . In

one embodiment, the primary connection surface has one or more areas which are close to the primary cavity border e.g. at a distance of 20 μm or less, such as 10 μm or less, such as 5 μm or less, and one or more areas where
5 the primary connection surface is at a larger distance from the primary cavity border e.g. a distance of between 25 and 500 μm , such as between 50 and 150 μm . These areas of the primary connection surface may be in direct contact with each other or one or more of them may be
10 separated from the other areas.

In one embodiment, the primary connection surface is extending around the primary cavity in an unbroken ring. In this embodiment, the primary connection may further
15 comprise additional areas separate from the ring formed primary connection area for mechanical stabilization of the sensor.

In one embodiment, the primary connecting surface is in
20 the form of two primary connecting surface sections separated from each other and extending along the border of the primary cavity.

In one embodiment, the primary connecting surface is in
25 the form of two primary connecting surface sections separated from each other and extending along opposite border of the primary cavity in the form of a channel.

The primary connecting surface comprises connection pads,
30 such as two or more, e.g. two connection pads for each piezoresistive element. The piezoresistive element or elements is/are electrically connected to these primary connecting pads on the primary connecting surface. This

may e.g. be performed using techniques as disclosed in WO 0066266, PCT/DK/0300117 or PCT/DK/0300042.

5 The primary connection surface may further comprise a barrier line which extends partly or totally around the primary cavity and has the purpose of stopping or blocking a filler, such as a glue, from overflowing the cavity barrier and filling up the cavity. The barrier line is in the form of a barrier wall, a barrier ditch or
10 both a barrier wall and a barrier ditch.

In one embodiment comprising a barrier line, the barrier line is in the form of a barrier ditch. The barrier ditch may e.g. have a depth of up to about 100 μm , such as up
15 to about 50 μm , such as up to about 25 μm . In one embodiment the barrier have a width of up to about 100 μm , such as between 5 and 50 μm , such as between 10 and 25 μm . The depth and the width may vary along the length of the line.

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In one embodiment the barrier line is in the form of a barrier wall. This barrier wall may in principle be of any type of material which is not soluble in or react with the liquid sample to be tested. In one embodiment,
25 the barrier wall is of glass or a metal e.g. a soldering material. In another embodiment, the barrier wall is of a polymer e.g. a glue, which essentially is not soluble in the solvent of the underfiller, that means that the barrier wall of polymer is not dissolved when the
30 underfiller is applied. The barrier wall may preferably have a height of 50 μm or less, such as 20 μm or less, such as 10 μm or less, such as 10 μm or less.

In embodiments, where the mounting is performed with bumps the barrier wall preferably has a height which is less than the height of the bumps, preferably about 0.5 times the height of the bumps or less.

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In one embodiment, the barrier wall may be placed relatively close to the primary cavity, such as at a distance of 20 μm or less, such as 10 μm or less, such as 5 μm or less. In another embodiment the barrier wall may
10 be placed larger distance to the primary cavity, such as at a distance of 20 μm or more, such as 50 μm or more, such as 75 μm or more, or the distance may vary along the length of the barrier wall.

15 The secondary substrate comprises secondary connecting pads corresponding to the primary connecting pads, on a secondary connecting surface corresponding to the primary connecting surface. The primary connecting surface and said secondary connection surface are mounted to each
20 other so that the primary connecting pads and the secondary connecting pads are directly mounted to each other, preferably in a flip chip mounting.

In one embodiment, wherein either the connection pads on
25 the primary pads or the secondary pads comprise a bump, the connecting pads are connected to each other using soldering.

In one embodiment, wherein either the connection pads on
30 the primary pads or the secondary pads comprise a bump, the connecting pads are connected to each other using an electrically conducting glue e.g. a thermoplastic glue.

The primary and the secondary connecting surfaces, respectively, are the surfaces of the primary substrate that are in tight connection with the secondary substrate and the surface of the secondary substrate that is in
5 tight connection with the primary substrate. The connection is in one embodiment constituted by the connection pads and adhesive.

By the terms "directly mounted to each other" is meant
10 that the connection pads, e.g. in the form of bumps of a conducting material, are directly electrically connected to each other without intermediate wiring. The bump may e.g. be performed by soldering material and the connection may in one embodiment be performed by
15 soldering the pads together.

In one embodiment, the secondary connection surface may further comprise a barrier line which extends partly or totally around a line corresponding to the border of the
20 primary cavity. This barrier line may be as described above. In one embodiment, the barrier line should preferably be placed relatively closely around a line corresponding to the border of the primary cavity, such as at a distance of 20 μm or less, such as 10 μm or less,
25 such as 5 μm or less. In one embodiment, the barrier line extends totally or partly around a cavity or an opening in the secondary substrate.

The secondary substrate may preferably comprise
30 electrical communication lines capable of providing an electrical connection between a power supply and the piezoresistive element(s), to thereby apply a voltage over the piezoresistive element(s).

In one embodiment, the primary connecting pads and the secondary connection are directly mounted to each other in a flip chip mounting. Flip chip mountings are generally known in the art for electrically mounting a die and a package carrier to each other e.g. for mounting a chip to a printed circuit board.

In one embodiment, the secondary substrate is a printed circuit board. The printed circuit board may preferably be a micro circuit board having the dimension of about 50x50 mm or smaller, such as about 15 x 30 mm or smaller, such as about 6x6 mm or smaller. The printed circuit area mounted to the primary substrate may in one embodiment constitute 100 mm² or less, such as around 50 mm² or less, such as around 36 mm² or less.

In one embodiment the secondary substrate is a micro chip e.g. with maximal dimensions of about 5000 µm or less, such as about 1000 µm or less, such as about 1000 µm or less. In one embodiment, the secondary substrate is a micro chip which comprises electrical connection lines for connection to a power supply.

In one embodiment, the secondary substrate may e.g. be a combined circuit board and flow chip. The circuit board may e.g. comprise an integrated or mounted flow chip for bringing and optionally withdrawing a liquid sample from the sensor.

The term flow chip is herein used to designate a liquid flow chip, i.e. a unit through which a liquid can flow e.g. by the use of a pump, capillary forces, gravity or a combination. The flow chip may e.g. be a micro flow chip e.g. where the flow channel in the flow chip has a cross

sectional area of about $100.000 \mu\text{m}^2$ or less, such as about $10.000 \mu\text{m}^2$ or less, such as about $1000 \mu\text{m}^2$ or less.

5 In one embodiment, the secondary substrate in the form of a circuit board comprises an opening for mounting a flow chip for bringing and optionally withdrawing a liquid sample from the sensor.

10 The secondary substrate may in principle be of any type of materials e.g. the materials mentioned above for the primary substrate. In one embodiment the secondary substrate is of a material selected from the group epoxy glass; LCP (Liquid Crystal Polymer); polyimide; polycarbonate; polyvinylchloride; ABS (Acrylonitrile-
15 Butadiene-Styrene); ceramic material such as alumina, mullite, glass, silicon, and combinations thereof.

In one embodiment, the secondary substrate is of an epoxy material, such as FR-4 or FR-5 epoxy glass. FR-4 or FR-5
20 epoxy glass is a group of well known materials and is e.g. marketed by Shell and National Electrical Manufacturers Association of USA. FR-4 epoxy resins, which are polyfunctional epoxy resins and in one particular embodiment of the invention is a difunctional brominated
25 epoxy resins. See e.g. Electronic Materials Handbook. ASM International (1989) at pages 534-537.

In one embodiment, the sensor has only one cantilever protruding from the primary substrate, the connecting
30 surface of the primary surface totally surrounds the primary cavity, and the secondary substrate comprises an opening through the substrate to provide access to the cantilever. Thereby the liquid sample can be added to the interaction chamber through the opening in the secondary

substrate e.g. in the form of a drop. The sensor in this embodiment may also be part of a dip stick.

5 In one embodiment, sensor has two or more cantilevers and each cantilever has its own primary cavity. The connecting surface of the primary surface totally surrounds the cavities of the primary surface, and the secondary substrate comprises openings through the substrate to provide access to the cantilevers.

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In one embodiment, the sensor has only one cantilever protruding from the primary substrate and into each interaction chamber constituted by a primary cavity and optionally by an opening in the secondary substrate above the primary cavity. The sensor comprises two or more primary cavities, and the secondary substrate comprises openings above said primary cavities. The primary cavities each have a primary connecting surface that totally surrounds it. The liquid sample can be added to the interaction chambers through the openings in the secondary substrate e.g. in the form of drops.

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In one embodiment, the primary cavity is in the form of a primary channel section. The primary channel section may preferably extend perpendicular to the protruding direction of the cantilever(s). Thereby an optimal contact between a liquid sample flowing e.g. with laminar flow through the channel section and the cantilever(s) can be obtained.

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In this embodiment, the primary connecting surface may e.g. be constituted by the surface along the lengthwise borders of the primary channel section. Thereby the channel section may have an inlet and outlet in opposite

ends of the channel sections where the inlet and outlet are in prolongation of the channel sections, and a liquid introduced through the channel section need not be subjected to turns.

5

In a variation of this embodiment, the primary connecting surface is constituted by the surface along all of the borders of the primary channel section. Thereby the inlet for the liquid may be in the side of the channel section, e.g. through an opening in the secondary substrate.

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The secondary substrate may comprise a secondary channel corresponding to the primary channel so that the primary and the secondary channels together form a flow channel section.

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In one embodiment, this flow channel section is closed except from an inlet in one of its ends, and an outlet in the other one of its ends. Thereby the flow channel section may have an inlet and optionally an outlet in opposite ends of the flow channel sections where the inlet and outlet are in prolongation of the flow channel sections.

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In one embodiment, the flow channel section comprises one or more openings through either the primary or the secondary substrate.

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In one embodiment, the primary channel section is in the form of an oblong cavity, the secondary substrate comprises an oblong opening corresponding to the primary channel section, the primary connecting surface surrounding the primary channel section and the secondary connection surface along the oblong opening being mounted

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to each other to form a flow channel section. In this embodiment, the liquid sample may be introduced through the secondary opening e.g. introduced in one end of the flow channel section and withdrawn from the other end of the flow channel section. This may e.g. be performed by mounting a flow chip above the opening in the secondary substrate.

In one embodiment, the sensor comprises two or more cantilevers protruding from the primary substrate in a row along the length of the primary channel section. In one embodiment, the sensor units comprise two rows of sensor units placed opposite each other and protruding into the channel section.

In one embodiment, the cross sectional area of the channel is about 0.1 mm^2 or less, such as about 0.05 mm^2 or less, such as about 0.01 mm^2 or less. Thereby a liquid flow through the flow channel will be laminar, and furthermore the amount of liquid necessary for performing a measurement is very low.

Since the dimensions of such sensors of the invention are very small it is actually surprising that this mounting technique has shown to be useful for the production. Thus it has been found to be possible to provide a sensor with a small interaction chamber which is reliable and with very low risk of short circuiting due to liquid interfering with the electrical connections.

Thus in one embodiment, the primary and the secondary connection surfaces are sealed in a liquid tight sealing. This sealing may in principle be provided in any way, but since the dimensions are often small care should be taken

not to clog the primary cavity with bonding material and the like.

In one embodiment, the liquid tight sealing comprises
 5 metal e.g. a metal sealing ring, polymer, glue or mixtures thereof. When using a metal sealing or sections of a metal sealing ring care should be taken that the metal sealing ring does not come into electrical contact with the primary and secondary connection pads, as this
 10 may result in a short circuiting of the system.

In one embodiment, the liquid tight sealing is totally or partly provided by soldering.

15 In one embodiment, the liquid tight sealing is totally or partly provided by glueing.

In one embodiment, the liquid tight sealing is totally or partly provided by underfiller, such as by underfilling
 20 of a polymer e.g. silicone and epoxy resin. Underfiller materials are well known in the art. Useful underfillers are as follows:

Ablebond E1172, Ablebond 7737s and Ablebond E1216, marketed by Emerson & Cuming, Canton, Massachusetts;
 25 Loctite 3563, Loctite 3564 and Loctite 3565 marketed by Loctite (Henkel Loctite Corp), Rocky hill, USA; Delo-Katiobond VE 4530 and Delo-Katiobond VE 4529, marketed by Industrieklebstoffe, Landsberg, Germany; and Chipcoat 8422, marketed by Namics Corporation, Japan.

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The underfiller may preferably have suitably viscosity during application so that the underfiller is forced into

an intermediate small space between the primary and secondary connection surface using capillary forces.

5 In one embodiment the one or more cantilevers comprise a capture surface of at least one of its major surfaces. The capture surface may be as described in WO 0066266, PCT/DK/0200779, PCT/DK/0300117, PCT/DK/0300042, PCT/DK/0300086, DK PA 2002 00884, DK PA 2002 01221, and DK PA 2002 00068.

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In one embodiment of the sensor according to the invention, the capture surface is a surface of a capture coating comprising a capture layer, wherein said capture layer is a layer comprising a detection ligand, said
15 detection ligand being a member of a specific binding pair wherein said detection ligand preferably is selected from the group consisting of RNA oligos, DNA oligos, PNA oligos, proteins, peptides, hormones, blood components, antigen and antibodies.

20

The capture coating could in principle have any thickness. If the capture coating is very thick, the sensitivity may be reduced due to the stiffness of the sensor unit. A desired thickness could e.g. be from
25 molecular thickness to 2000 nm, such as up to, 2, 5, 10 or 50 molecule layers, or e.g. between 0.5 nm and 1000 nm, such as between 1 and 500 nm, such as between 10 and 200 nm.

30 In one embodiment, both or a part of both of the two major sides of the cantilever comprise a capture surface. The capture surfaces may be identical or they may differ from each other e.g. with respect to size of area covered, type of capture molecules and/or concentrations

thereof. In one embodiment, the capture surface on one major side of a cantilever is essentially identical, - both with respect to size of area covered, type of capture molecules and concentrations - to the capture surface on the other one of the two opposite major surfaces of the cantilever.

Brief description of drawings

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Figure 1 is a cross-sectional side view of a sensor according to the invention.

Figure 2 is a cross-sectional top view of the sensor shown in Figure 1, where the secondary substrate has been removed.

Figure 3 is a schematic and exploded perspective view of a sensor according to the invention.

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Figure 4 is a schematic and exploded perspective view of a variation of the sensor shown in Figure 3.

Figure 5 is a schematic and exploded perspective view of a variation of the sensor shown in Figures 3 and 4.

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Figure 6 is a cross-sectional side view of a variation of the sensor shown in Figure 1.

Figure 7 is a top view of a not mounted secondary substrate.

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Detailed description of drawings

Figure 1 is a cross-sectional view of a chemical sensor of the invention. The sensor comprises a primary substrate 1 having one or more cantilevers 3 protruding from the primary substrate 1. The cantilevers 3 are
5 suspended above a primary cavity 2 constituted by an etched recess 2.

Furthermore, the primary substrate 1 is provided with bumps 8 for flip-chip assembly. The sensor also comprises
10 a secondary substrate 4 which is provided with electrically conducting pads 7 and an opening 9. In the flip-chip assembly process, the primary substrate 1 is mounted onto the surface 5 of the secondary substrate 4 so that the opening 9 is positioned over the etched
15 recess 2 in the primary substrate. The spacing between the primary substrate 1 and the secondary substrate 4 is filled with a glue 6, preferably an underfiller. The primary connecting surface is constituted by the part of the primary substrate and the part of the primary pads 12
20 that are in contact with the glue 6 and the bumps 8 that connect the substrates to each other, and the secondary connecting surface is constituted by the secondary pads and the part of the surface 5 of the secondary substrate 4 that are in contact with the glue 6 and the bumps 8
25 that connect the substrates to each other.

After the underfilling process, the opening 9 and the recess 2 form a channel section 10 that can guide a liquid sample to the cantilevers 3. The underfiller 6
30 separates the electrically conductive pads 7 from the liquid in channel section 10, and therefore the sensor can be used for measuring in conductive liquids without risk of short circuiting.

Figure 2 shows a cross-sectional top view of the sensor shown in Figure 1 where the secondary substrate has been removed. The primary substrate 1 in this example, is linked to four cantilevers 3. Each cantilever 3 comprises a piezoresistive strain-gauge 11. The electrical connections to the strain-gauge resistor are provided by the bond pads 12. The primary substrate 1 also comprises extra bond pads 13 for stabilising the semiconductor body during flip-chip mounting.

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Figure 3 is a schematic and exploded perspective view of a sensor according to the invention, where the filler material and the bumps that connect the primary substrate 31 and the secondary substrate 32 to each other, are not shown. The primary substrate 31 comprises a cavity 33 in the form of a channel section, and two cantilevers 34 protruding into the cavity 33. The cantilever 34 comprises not shown piezoresistive elements, which are in electrical connection with the primary pads 35. The secondary substrate 32 comprises secondary pads 36 corresponding to the primary pads 35. The secondary pads 36 are each connected to a communication pad 37 through which a not shown power supply can be connected. The secondary substrate 32 further comprises two openings 38 through the secondary substrate 32 positioned above the respective endings of the channel section 33. When mounted together, a sealing is applied between the primary and the secondary connection surface which in this example extends around the border of the primary cavity 33. A liquid sample can thereafter be introduced and withdrawn through the openings 38. The secondary substrate further comprises a not shown cavity to be placed above the cantilevers so that the cantilevers

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freely can deflect if stress is generated on their surfaces.

Figure 4 is a schematic and exploded perspective view of a variation of the sensor shown in Figure 3, where the filler material and the bumps that connect the primary substrate 341 and the secondary substrate 42 to each other, are not shown. The primary substrate 41 comprises a cavity 43 in the form of a channel section and two cantilevers 44 protruding into the cavity 43. The cantilever 44 comprises not shown piezoresistive elements which are in electrical connection with the primary pads 45. The secondary substrate 42 comprises secondary pads 46 corresponding to the primary pads 45. The secondary pads 46 are each connected to a communication pad 47 through which a not shown power supply can be connected. The secondary substrate 42 further comprises one opening 48 through the secondary substrate 42 positioned above the channel section 43. When mounted together, a sealing is applied between the primary and the secondary connection surface which in this example extends around the border of the primary cavity 43. A liquid sample can thereafter be introduced through the opening 48. The sensor may e.g. be mounted with a flow chip which can provide a partial cover to the middle part of the channel section 43 so that liquid can be introduced and withdrawn via the flow chip and pass along the length of the channel section.

Figure 5 is a schematic and exploded perspective view of a variation of the sensor shown in Figures 3 and 4, where the filler material and the bumps that connect the primary substrate 51 and the secondary substrate 52 to each other, are not shown. The primary substrate 51

comprises a cavity 53 in the form of a channel section passing across the primary substrate 51, and two cantilevers 54 protruding into the cavity 53. The cantilever 54 comprises not shown piezoresistive elements which are in electrical connection with the primary pads 55. The secondary substrate 52 comprises secondary pads 56 corresponding to the primary pads 55. The secondary pads 56 are each connected to a communication pad 57 through which a not shown power supply can be connected. The secondary substrate further comprises a cavity 58 arranged to be placed above the cantilevers so that the cantilevers freely can deflect if stress is generated on their surfaces.

When mounted together, a sealing is applied between the primary and the secondary connection surface which in this example extends along the borders of the primary cavity 53 following the length direction of the channel section 53. Two openings for introducing and withdrawing of liquid sample will thereby be formed in prolongation of the channel endings.

Figure 6 is a cross-sectional side view of a variation of the sensor shown in Figure 1, wherein the sensor further comprises a barrier wall 11. The remaining parts of the sensor are as described above for Figure 1.

The barrier wall 11 prevents the underfiller from flowing into the primary cavity 2.

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Figure 7 is a top view of a not mounted secondary substrate seen from the face adapted to be mounted together with a primary substrate. The secondary substrate comprises an opening 79, electrically

conducting pads 77, pads for a stabilising connection 73 and a barrier wall 71 in two sections. As seen the distance between the border line 79a of the opening 79 and the barrier wall may vary. The border line 79a preferably corresponds to the borderline of the primary cavity of the primary substrate to which the secondary substrate is supposed to be mounted with.

Patent Claims:

1. A chemical sensor comprising one or more sensor
5 units, a primary and a secondary substrate, the primary
substrate comprises a primary cavity and a primary
connecting surface at least partly surrounding said
cavity, the one or more sensor units are in the form of
cantilevers, each comprising a piezoresistive element,
10 said one or more sensor units are protruding from the
primary substrate and into the cavity of said primary
substrate, the piezoresistive element or elements being
electrically connected to primary connecting pads on the
primary connecting surface, the secondary substrate
15 comprises secondary connecting pads corresponding to the
primary connecting pads, on a secondary connecting
surface corresponding to the primary connecting surface,
said primary connecting surface and said secondary
connection surface being mounted to each other so that
20 said primary connecting pads and said secondary
connecting pads being direct mounted to each other,
preferably in a flip chip mounting.

2. A chemical sensor according to claim 1 wherein
25 the sensor has one cantilever protruding from the primary
substrate, the connecting surface of the primary surface
totally surrounds the primary cavity, and the secondary
substrate comprises an opening through the substrate to
provide access to the cantilever.

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3. A chemical sensor according to claim 2 wherein
the sensor has two or more cantilevers, each cantilever
has its own primary cavity, the connecting surface of the
primary surface totally surrounds the cavities of the

primary surface, and the secondary substrate comprises openings through the substrate to provide access to the cantilevers.

5 4. A chemical sensor according to any one of the preceding claims wherein the primary cavity is in the form of a primary channel section, said primary channel section preferably extending perpendicular to the protruding direction of the cantilever(s).

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5. A chemical sensor according to claim 4 wherein the primary connecting surface is constituted by the surface along the lengthwise borders of the primary channel section.

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6. A chemical sensor according to claim 4 wherein the primary connecting surface is constituted by the surface along all of the borders of the primary channel section.

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7. A chemical sensor according to any one of the claims 4-6 wherein the secondary substrate comprises a secondary channel corresponding to the primary channel so that the primary and the secondary channels together form

25 a flow channel section.

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8. A chemical sensor according to claims 7 wherein the flow channel section is closed except from an inlet in one of its ends and an outlet in the other one of its ends.

9. A chemical sensor according to claim 7 wherein the flow channel section comprises one or more openings through either the primary or the secondary substrate.

10. A chemical sensor according to claim 6 wherein the primary channel section is in the form of an oblong cavity, the secondary substrate comprises an oblong opening corresponding to the primary channel section, the primary connecting surface surrounding the primary channel section and the secondary connection surface along the oblong opening being mounted to each other to form a flow channel section.
11. A chemical sensor according to any one of the claims 4-10 wherein the sensor comprises two or more cantilevers protruding from the primary substrate along the length of the primary channel section.
12. A chemical sensor according to any one of the preceding claims wherein the primary connecting surface comprises a barrier line extending partly or totally around the primary cavity, said barrier line being in the form of a barrier wall, a barrier ditch or both a barrier wall and a barrier ditch.
13. A chemical sensor according to any one of the preceding claims wherein the secondary connecting surface comprises a cavity or an opening in the secondary substrate, said secondary substrate further comprising a barrier line extending partly or totally around the cavity or the opening in the secondary substrate, said barrier line preferably being of a metal.
14. A chemical sensor according to any one of the preceding claims wherein the primary and the secondary connection surfaces are sealed in a liquid tight sealing.

15. A chemical sensor according to claim 14 wherein the liquid tight sealing comprises metal e.g. a metal sealing ring, polymer, glue or mixtures thereof.

5 16. A chemical sensor according to any one of the claims 14 and 15 wherein the liquid tight sealing is totally or partly provided by soldering.

10 17. A chemical sensor according to any one of the claims 14-16 wherein the liquid tight sealing is totally or partly provided by underfilling, such as by underfilling of a polymer e.g. Silicone and epoxy resin.

15 18. A chemical sensor according to any one of the preceding claims wherein the secondary substrate comprises electrical communication lines capable of providing an electrical connection between a power supply and the piezoresistive element(s), to thereby apply a voltage over the piezoresistive element(s).

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19. A chemical sensor according to any one of the preceding claims wherein the secondary substrate is of a ceramic material such as, alumina, mullite, glass, silicon, an epoxy material such as FR-4 or FR-5 epoxy
25 glass, and combinations thereof.

20. A chemical sensor according to any one of the preceding claims wherein the secondary substrate is a printed circuit board.

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21. A chemical sensor according to any one of the preceding claims wherein the secondary substrate is a micro chip.

22. A chemical sensor according to any one of the preceding claims wherein said primary substrate comprises one or more of the materials selected from the group consisting of silicon (including polysilicon and single
 5 crystal silicon), silicon nitride, silicon oxide, metal, metal oxide, glass and polymer, wherein the group of polymers preferably includes epoxy resin e.g. an octafunctional epoxidized novalac, polystyrene, polyethylene, polyvinylacetate, polyvinylchloride,
 10 polyvinylpyrrolidone, polyacrylonitrile, polymethylmetacrylate, polytetrafluoroethylene, polycarbonate, poly-4-methylpentylene, polyester, polypropylene, cellulose, nitrocellulose, starch, polysaccharides, natural rubber, butyl rubber, styrene
 15 butadiene rubber and silicon rubber.

23. A chemical sensor according to claim 22 wherein said primary substrate is based on silicon, said primary cavity being in the form of a etched cavity forming a
 20 recess under the one or more cantilever(s).

24. A sensor according to any one the preceding claims wherein the piezoresistive element consists of one or more of the materials silicon (including polysilicon
 25 and single crystal silicon), metal or metal containing composition, e.g. gold, AlN, Ag, Cu, Pt and Al conducting polymers, such as doped octafunctional epoxidized novalac e.g. doped SU-8, and composite materials with an electrically non-conducting matrix and a conducting
 30 filler, wherein the filler preferably is selected from the group consisting of polysilicon, single crystal silicon, metal or metal containing composition, e.g. gold, AlN, Ag, Cu, Pt and Al, semi-conductors, carbon

black, carbon fibres, particulate carbon, carbon nanowires, silicon nanowires.

25. A sensor according to any one the preceding
5 claims wherein said one or more cantilevers comprise a
capture surface of at least one of its major surfaces.

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Abstract:

The invention relates to a chemical sensor comprising one or more cantilever sensor units with a piezoresistive element for direct read out. The sensor comprises a primary substrate carrying the cantilevers and with a primary cavity and a primary connecting surface at least partly surrounding said cavity. The cantilevers protrude into the primary cavity. The piezoresistive elements are electrically connected to primary connecting pads on the primary connecting surface. The sensor also comprises a secondary connecting pads corresponding to the primary connecting pads, on a secondary connecting surface corresponding to the primary connecting surface. The primary connecting surface and the secondary connection surface are mounted to each other so that said primary connecting pads and said secondary connecting pads are direct mounted to each other, preferably in a flip chip mounting.

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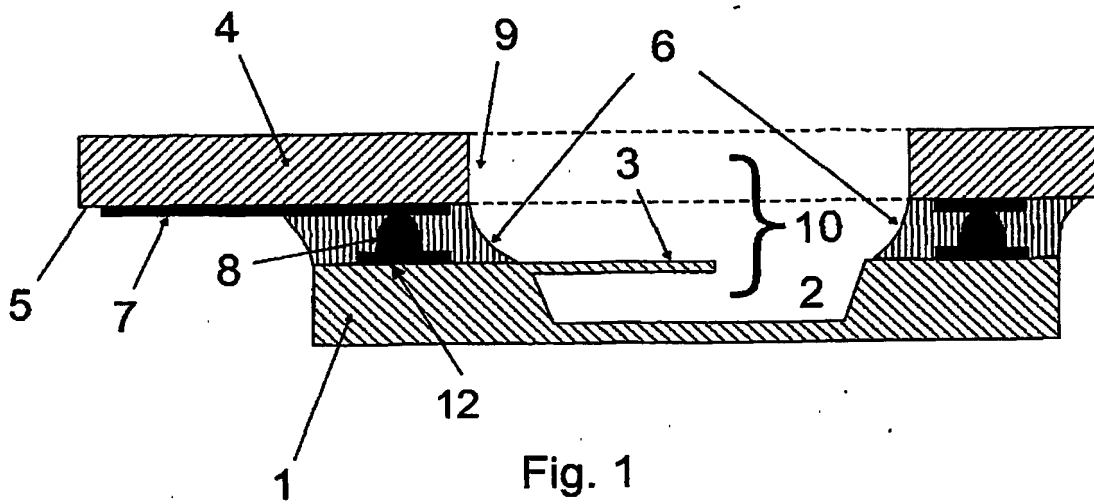


Fig. 1

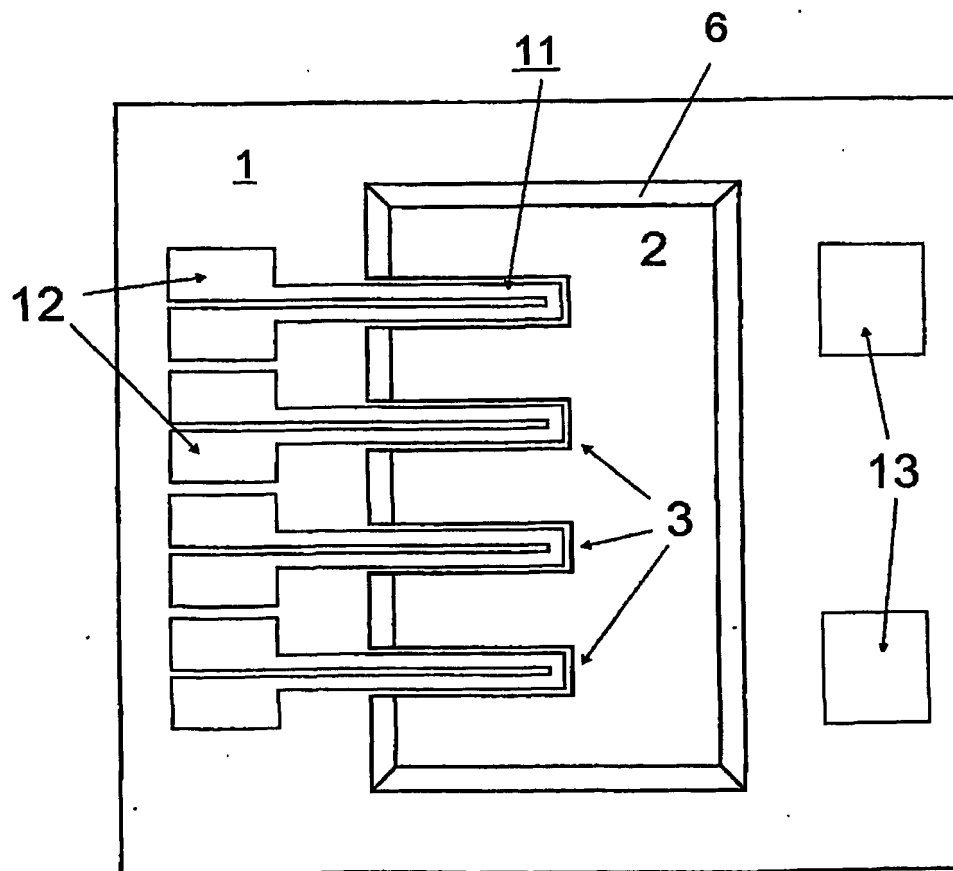


Fig. 2

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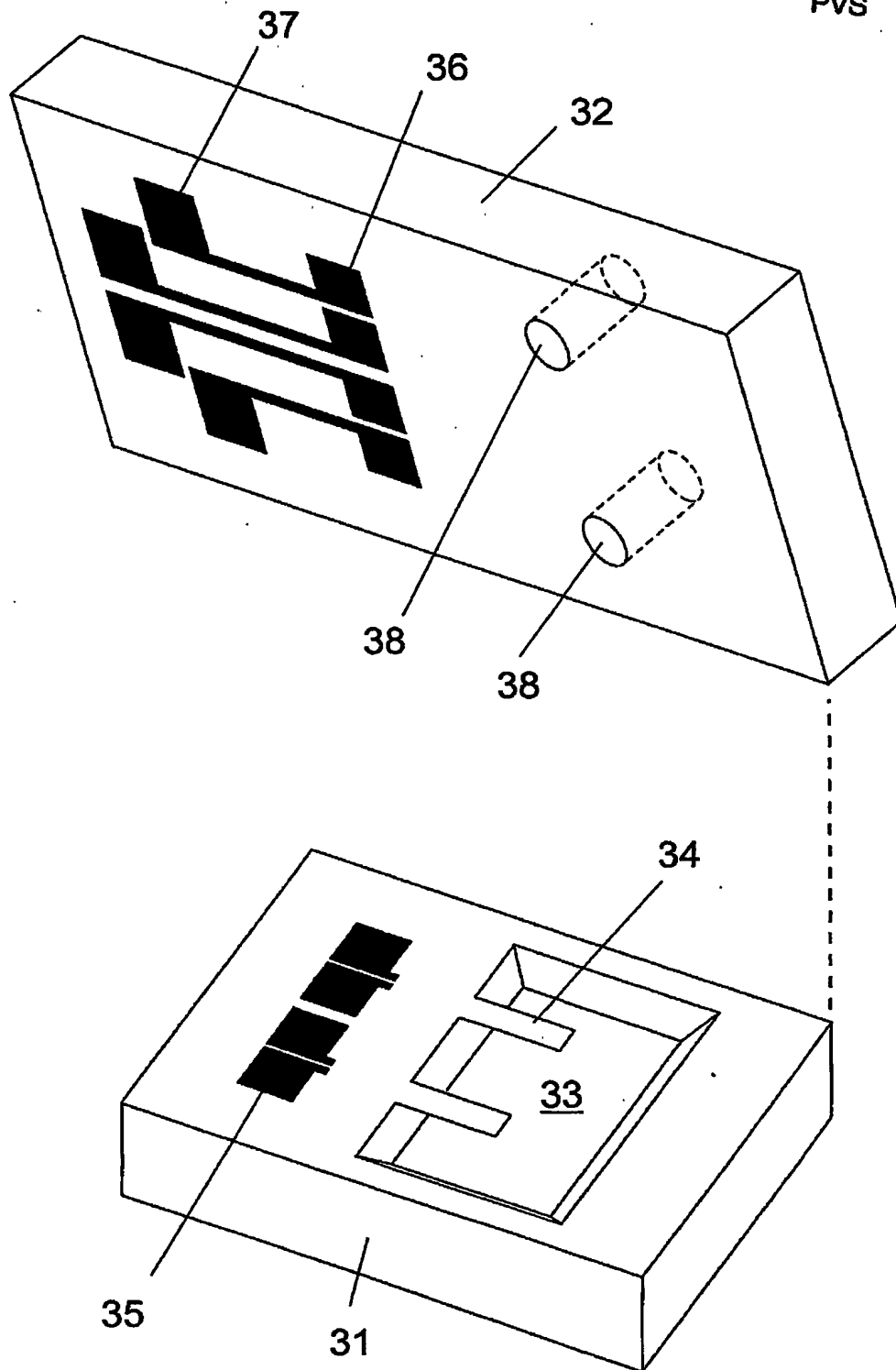


Fig. 3

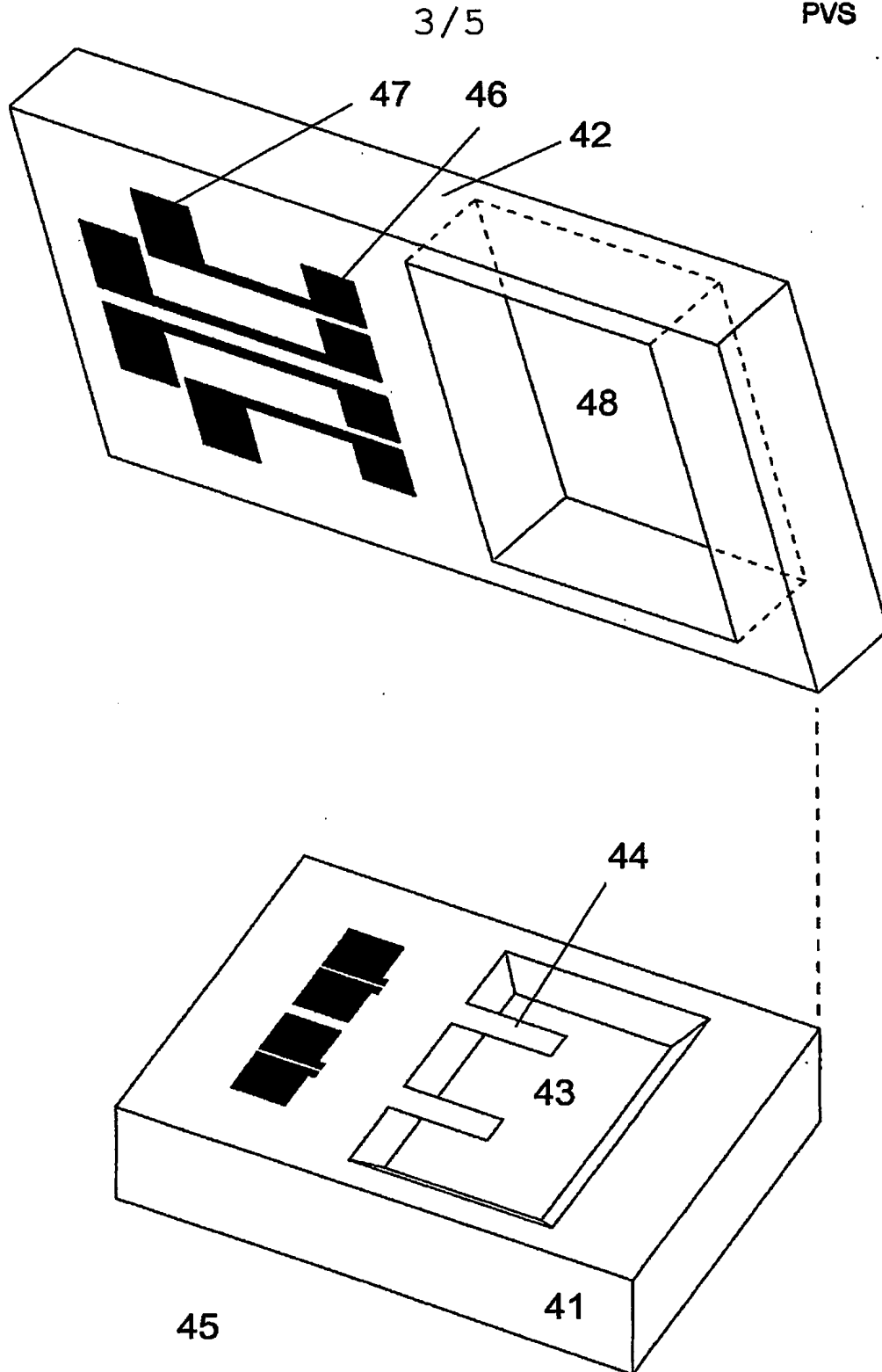


Fig. 4

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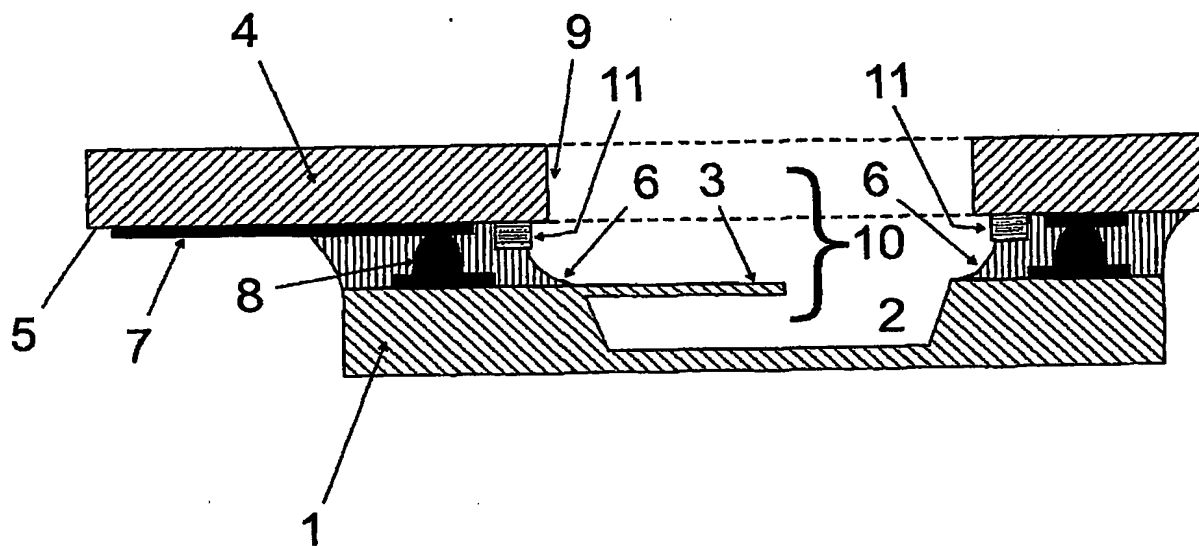


Fig. 6

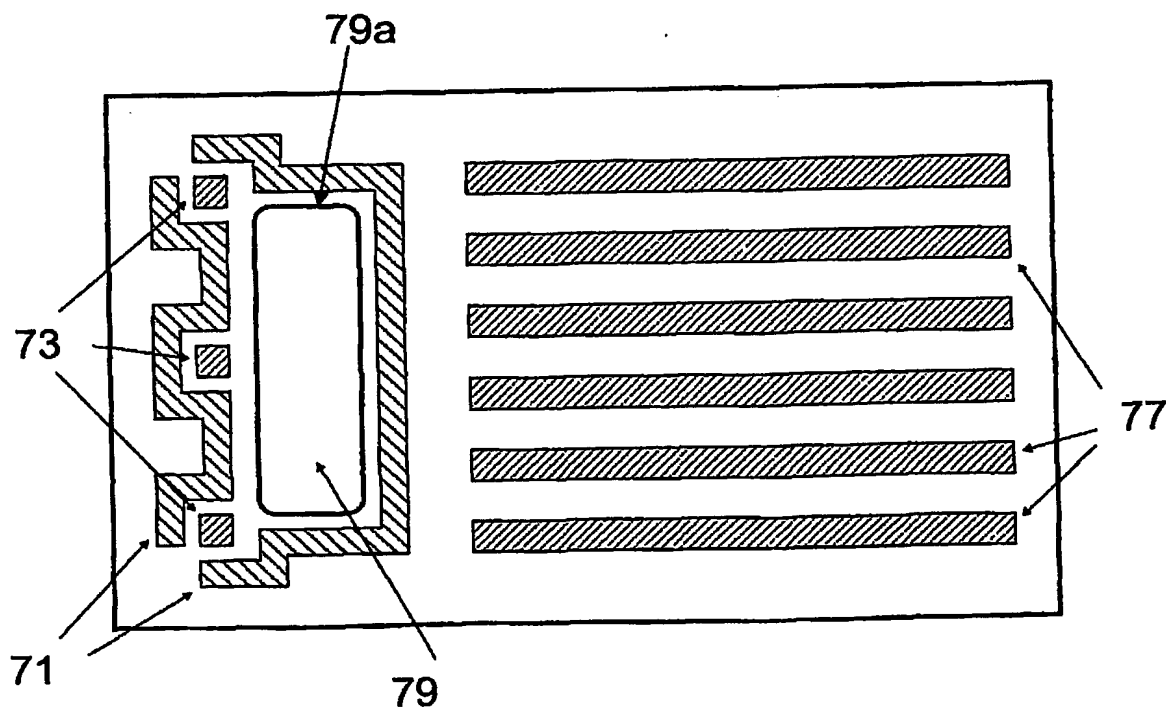


Fig. 7